

Notice of References Cited	Application/Control No. 10/766,591		Applicant(s)/Patent Under Reexamination CHEN ET AL.	
	Examiner CHRYSTINA ZELASKIEWICZ		Art Unit 3621	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0050114	03-2003	Leen et al.	463/25
*	B	US-6,758,754	07-2004	Lavanchy et al.	463/42
*	C	US-6,468,155	10-2002	Zucker et al.	463/23
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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